

Search Notes

Application/Control No.

10/720,525

Examiner

Mathieu D. Vargot

Applicant(s)/Patent under
Reexamination

LIN, JUNG KAN

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	1.7, 1.31, 272.11, 272.14, 275	1/6/06	MDV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR